



# Reconstruction of $Z \rightarrow \tau\tau \rightarrow e+\tau$ jet events with early data in CMS

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## Overview

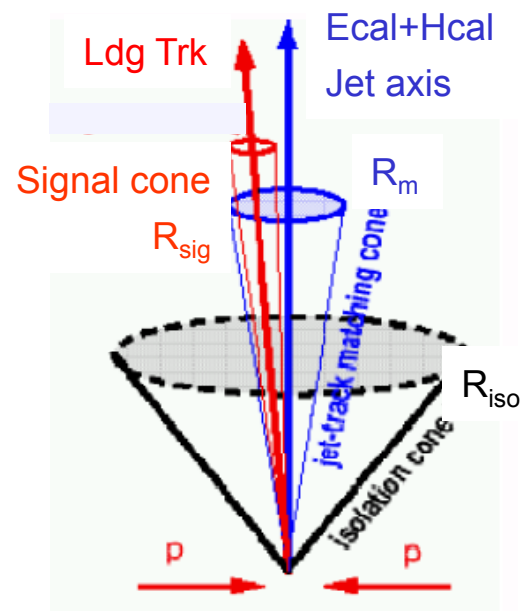
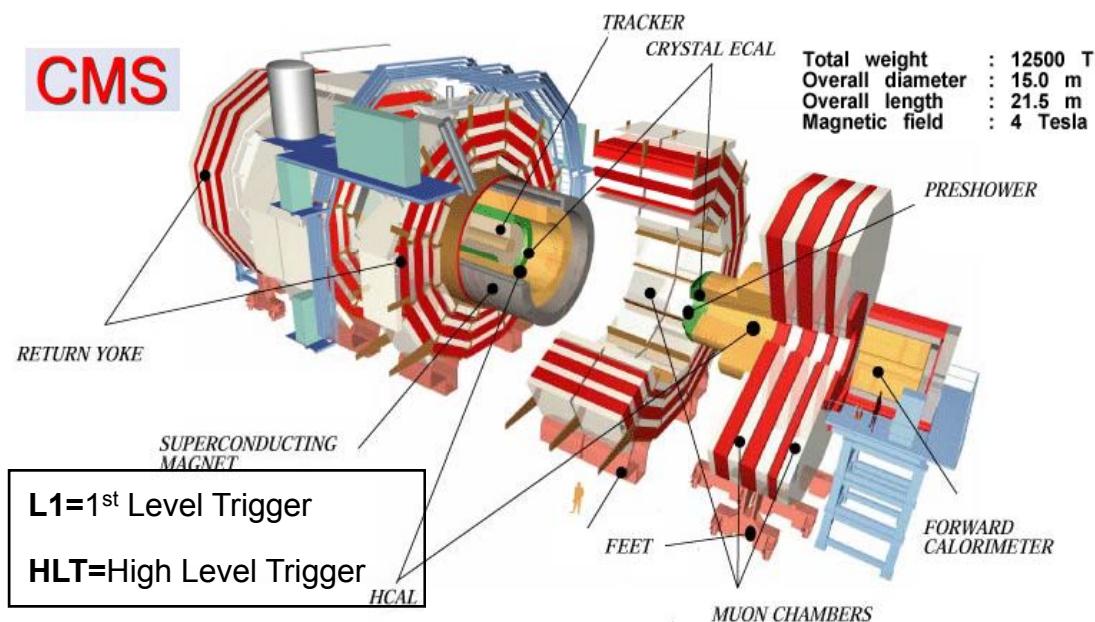
- Motivation
- Detector and algorithm description
- Aspects of  $\tau$  jet reconstruction
- Results
- Background estimation
- Conclusions



# Introduction

- Motivation for reconstructing and selecting  $Z \rightarrow \tau\tau \rightarrow e+\tau$  jet events
  - Benchmark for light SM/SUSY  $H \rightarrow \tau\tau \rightarrow e+\tau$  jet discoveries
  - Main channel to measure  $\tau$  jet tagging efficiency
    - Vital ingredients for the measurement of x-section of events involving  $\tau$  jets
    - Input to measurements of SUSY studies
- Analysis is based on methods to be applied on data from first physics run
  - Events have been simulated accounting for the detector conditions (calibration, alignment) with the first  $100\text{pb}^{-1}$  of data

# The CMS Detector



**Electron L1+HLT:** Calorimeter isolation at L1. At HLT build Ecal clusters out of “L1 accepted” objects. Build pixel seeded tracks and require E/P, HCal and Tracker isolation cuts.

**Offline Electron Id:** Based on H/E, E/P, cluster shape, brem fraction, track-cluster matching ...cuts.

**Tau Jet L1+HLT:** Calorimeter isolation at L1. At HLT build calo-jets out of “L1 accepted objects”. Build pixel seeded tracks and require Ecal and Pixel/Track isolation

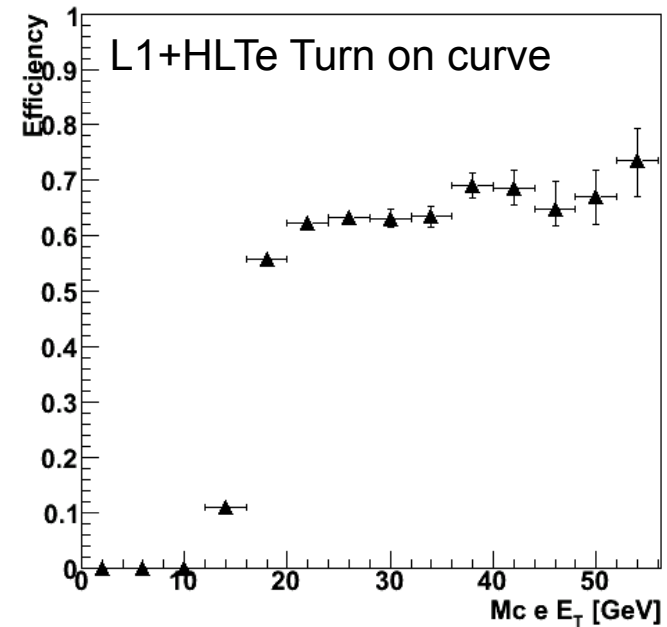
**Tau Jet Offline:** Calo/PF jet with isolated tracks. Variations of isolation (varying  $R_s$ ,  $\eta-\phi$ ,  $\theta-\phi$  cone definitions.... )

# Triggering on $Z \rightarrow \tau\tau \rightarrow e + \tau$ jet



- Ideally trigger using HLT  $e + e\tau$  jet trigger
- At  $10^{32} \text{cm}^{-2} \text{s}^{-1}$ : HLT $e$   $E_T^e > 15 \text{GeV}$   
 HLT $e + \tau$ jet  $E_T^e > 12 \text{GeV}$   $E_T^{\tau \text{ jet}} > 20 \text{GeV}$
- No gain of HLT $e + \tau$  jet on top of HLT $e$  at  $10^{32} \text{cm}^{-2} \text{s}^{-1}$
- HLT $e + \tau$  jet becomes important at higher L scenario when HLT $e$   $E_T$  threshold increases
- Therefore trigger on these events using HLT $e$

Level-1+HLT  $e + e\tau$  (22.9 $\pm$ 0.4)%  $\sim$ (12 $\pm$ 4)Hz  
 Level-1+HLT  $e$  (22.4 $\pm$ 0.4)%  $\sim$ (12 $\pm$ 4)Hz

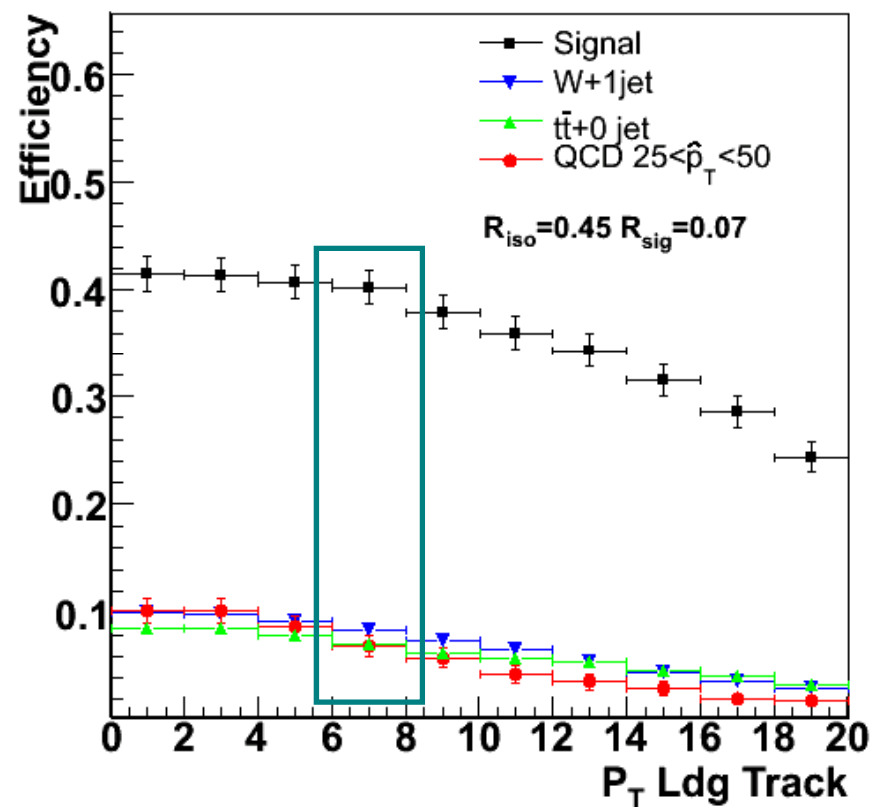
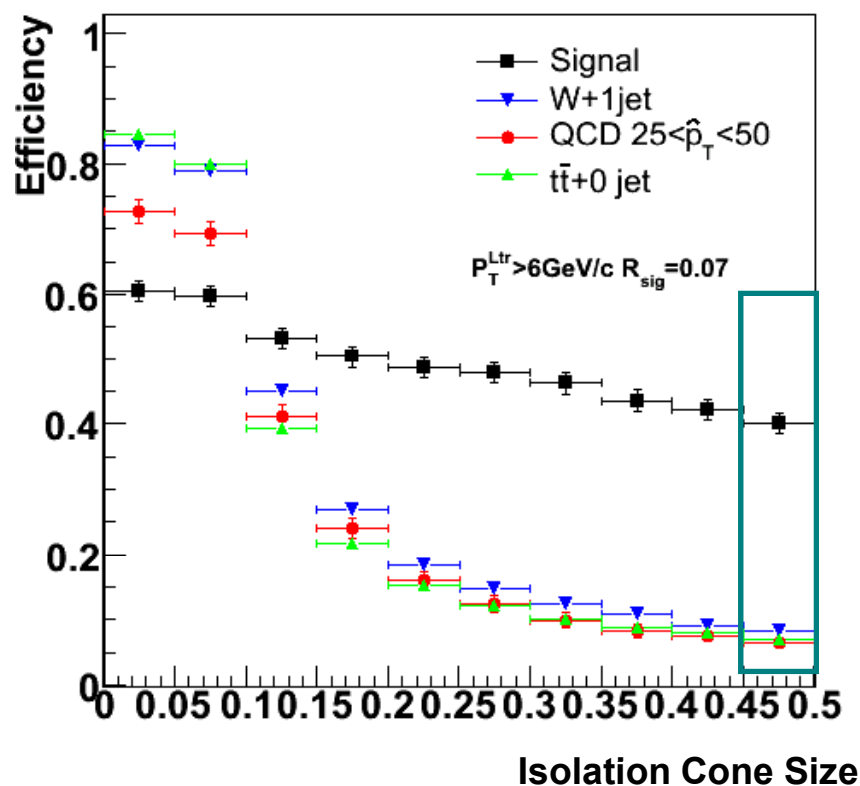


HLTe = Single electron HLT  
 HLT $e + \tau$  jet = Single electron AND  $\tau$  jet HLT  
 HLT  $e + e\tau$  jet = HLT $e$  OR HLT $e + \tau$  jet

# Offline $\tau$ jet tracker isolation performance

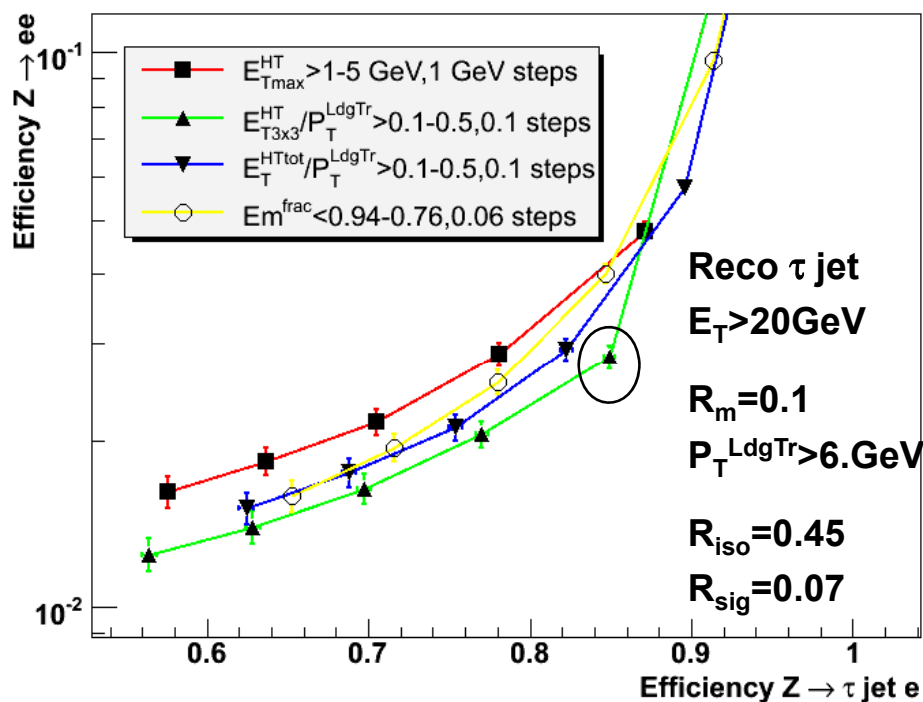
Ldg Trk Finding efficiency factored in

$E_T > 20\text{GeV}$  Pass electron Rejection



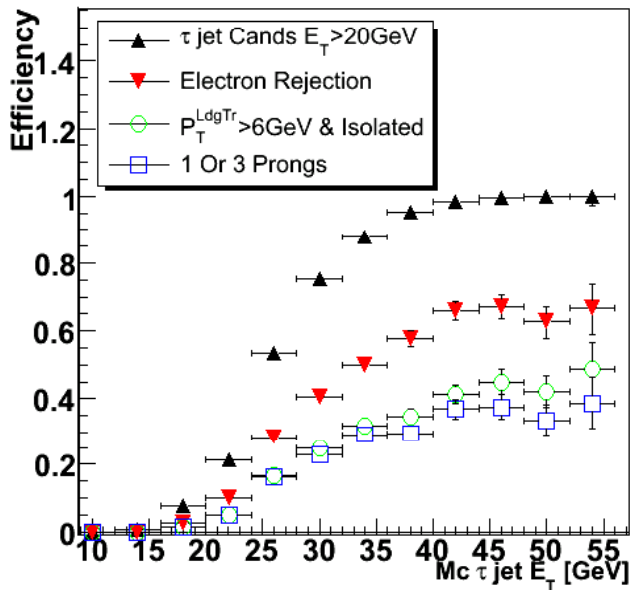
# e- $\tau$ jet misidentification

- Electrons are ideal candidates to pass  $\tau$  jet identification criteria since they are single isolated tracks. Need to be able to reject them.
  - $E_{Tmax}^{HT} = \text{Max Hcal Tower } E_T \text{ of Jet}$
  - $Em^{frac} = \text{EM fraction of Jet}$
- Best performance by  $E_{T3x3}^{HT}/P_T^{LdgTr} = \text{Sum of 3x3 HCal Tower } E_T \text{ around leading track impact point on Calo Surface divided by Ldg Trk } P_T$

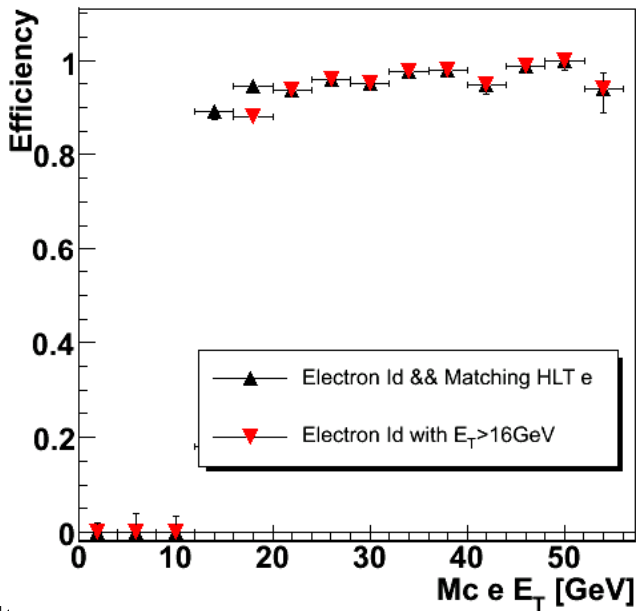
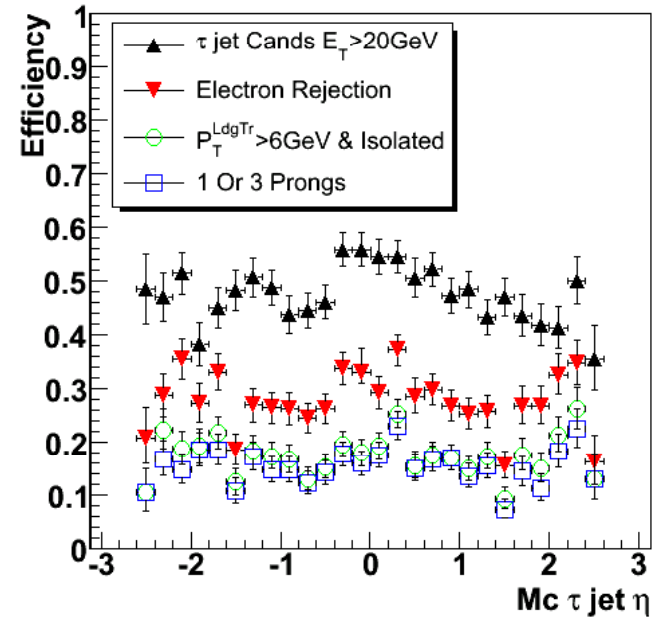


- For  $E_{T3x3}^{HT}/P_T^{LdgTr} > 0.1$ 
  - $(85 \pm 0.2)\%$   $\tau$  jet efficiency
  - $(2.7 \pm 0.2)\%$  e efficiency
- Further apply veto for candidates with LdgTr @ Ecal pointing to  $\eta$  cracks giving a total
  - $\sim 80\%$   $\tau$  jet efficiency
  - $\sim 1\%$  e efficiency

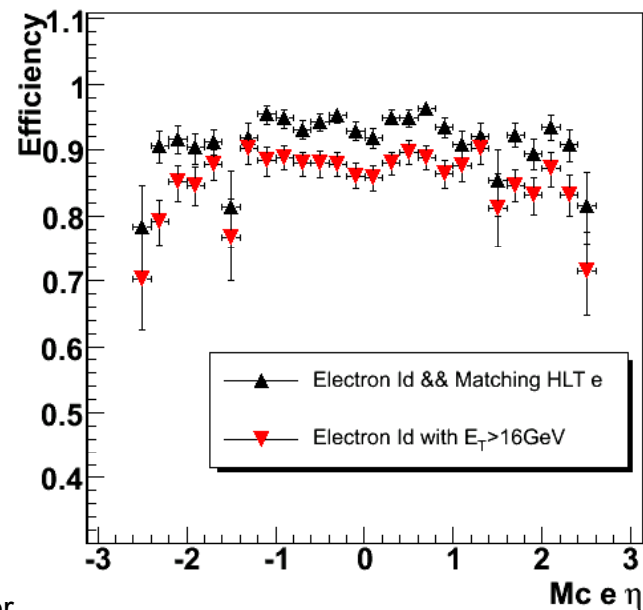
# Offline Signal Performance



$\tau$  jet id eff



e id eff  
w.r.t HLT



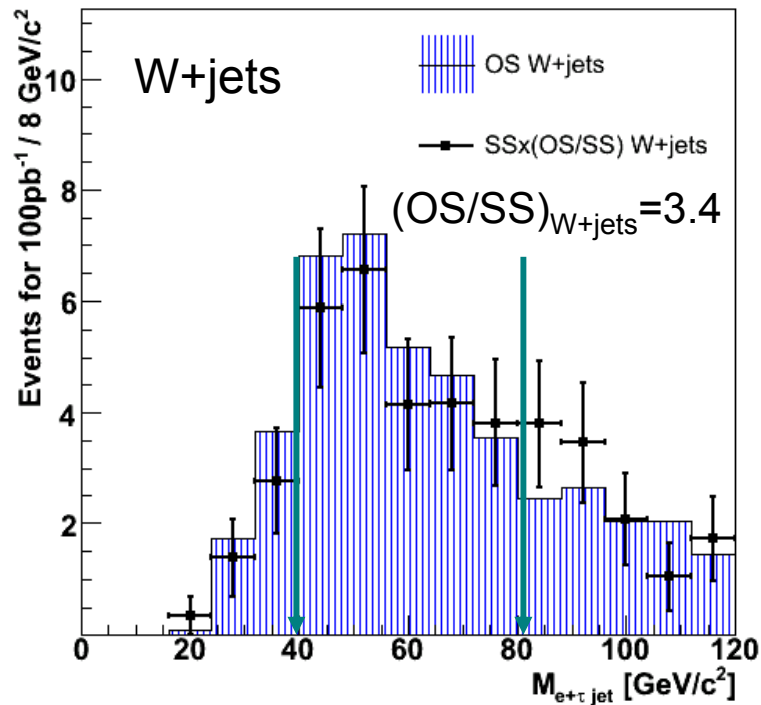
# Background Estimation

- The charges of the electron and  $\tau$  jet in Signal events are opposite
  - This gives a good handle for selecting a Signal-Free mass window by looking at Same Sign (SS)  $M_{e+\tau \text{ jet}}$
  - Background contribution in the Opposite Sign (OS) mass window can be extracted by looking at the number of events and shape of the SS mass window
- Treat QCD and EWK processes separately
  - Use dedicated analyses to get the number of events for the corresponding luminosity and apply the selections efficiencies obtained from MC simulations to extract  $N_{W+jets}^{SS}$ ,  $N_{t\bar{t}}^{SS}$ ,  $N_{Z+jets \rightarrow ee}^{SS}$
  - The  $(OS/SS)_{EWK}$  ratios are obtained from MC simulations and verified with data
  - For QCD:  $N_{QCD}^{SS} = N_{data}^{SS} - N_{W+jets}^{SS} - N_{t\bar{t}}^{SS} - N_{Z+jets}^{SS}$
  - And  $(OS/SS)_{QCD}$  can be obtained by looking at events passing a Non-Isolated electron trigger. This trigger has just been approved by CMS so this study is ongoing



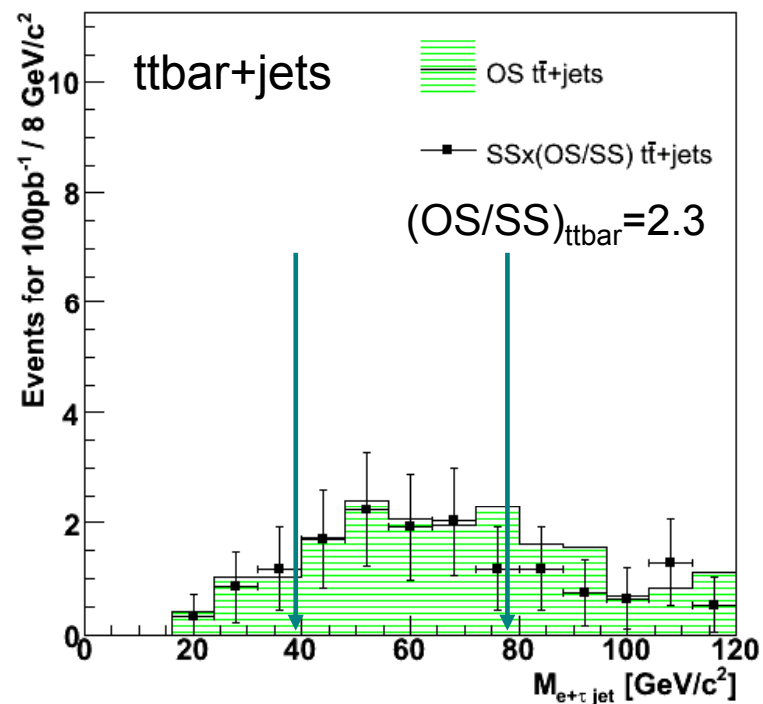
# W+jets and ttbar Background Estimation

Extracting Visible OS mass dist'n from SS  $N^{OS} = N^{SS} \times (OS/SS)_{MC}$



$$N^{OS} = 27.5$$

$$N^{SS} \times (OS/SS)_{MC} = 25$$



$$N^{OS} = 10.4$$

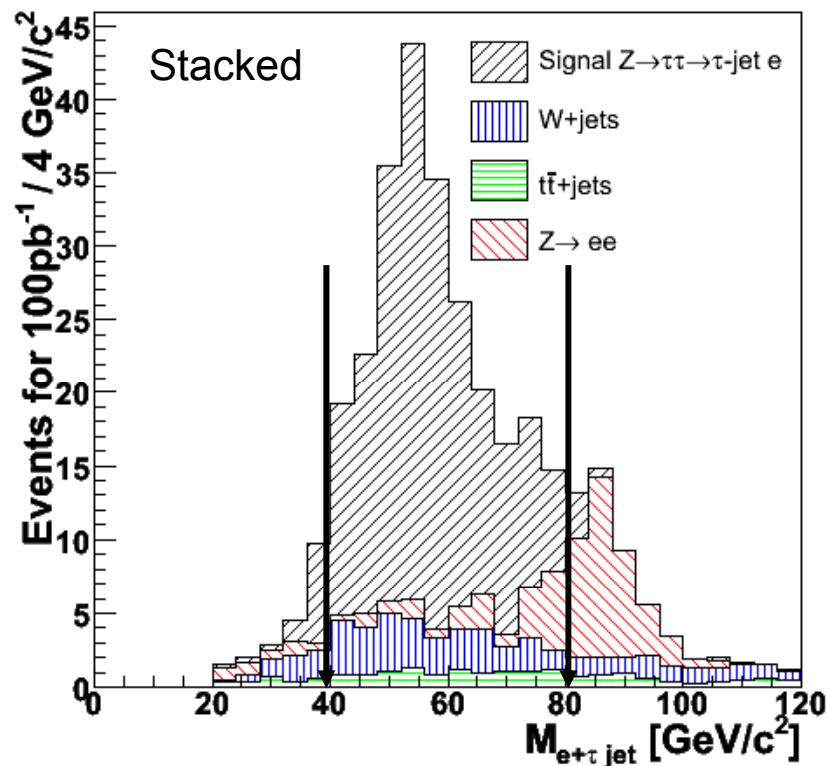
$$N^{SS} \times (OS/SS)_{MC} = 9$$

# Z->ee Background Estimation

- Extract OS Z->ee contribution by looking at events with reverse electron rejection criteria  $E_{T3x3}^{HT}/P_T^{LdgTr} < 0.1$  ( $\tau$ -veto)
- Hence  $N_{Z \rightarrow OS}^{e\text{-veto}} = N_{Z \rightarrow ee OS}^{\tau\text{-veto}} \times \epsilon_{Z \rightarrow ee}^{e\text{-veto}} / \epsilon_{Z \rightarrow ee}^{\tau\text{-veto}}$
- This requires knowledge of  $\epsilon_{Z \rightarrow ee}^{e\text{-veto}} / \epsilon_{Z \rightarrow ee}^{\tau\text{-veto}}$  which can be extracted using “Tag and Probe” methods (See Backup)
- Can also extract mass shape however there are still some discrepancies that need to be understood

# Mass Plot

Look at invariant mass between Opposite Sign (OS) reconstructed visible Z products  $M_{e+\tau \text{ jet}}$  since want to minimise the use of Missing  $E_T$  at startup



**Scaled to  $100\text{pb}^{-1}$  from 1<sup>st</sup> physics run**

Signal: 195.8

W+jets: 27.5

$t\bar{t}$ +jets: 10.4

$Z \rightarrow ee$ : 17

$S/\sqrt{(S+B)} \sim 26$

Contribution of QCD is currently being evaluated



# Conclusions

- Presented a brief description of some of the aspects of selecting and reconstructing  $Z \rightarrow \tau\tau \rightarrow e + \tau$  jet events
- Performance of the algorithms was discussed
- For  $100\text{pb}^{-1}$  we have  $\sim 200$  Signal with  $\sim 55$  Bkg events (QCD omitted)
  - Effect of QCD is currently being studied.
- Methods for extracting the number and shape of background events from data were discussed
- Finally data driven methods for measuring the “per jet”  $\tau$  tagging efficiency are being studied.



# Backup



# Samples used

- Data Sets used

- Signal: Pythia  $Z \rightarrow \tau\tau \rightarrow e + \tau$  jet with  $|\eta|_{e,\tau,\text{jet}} < 2.5$   $70\text{GeV}/c^2 < m_Z < 110\text{GeV}/c^2$
- Pythia  $Z \rightarrow ee$   $|\eta|_e < 2.5$   $m_Z > 40\text{GeV}/c^2$
- Alpgen  $W + 0, 1, 2$  jets
- Alpgen  $t\bar{t} + 0, 1, 2$  jets
- Pythia QCD  $p_T^{\text{hat}} 25\text{-}170\text{GeV}$

# Triggering on $Z \rightarrow \tau\tau \rightarrow e + \tau$ jet events

- Ideally a logical OR between Single Isolated e HLT (e HLT) and the X-channel  $e\tau$  HLT should be used
  - However current trigger table designed for  $L=10^{32}\text{cm}^{-2}\text{s}^{-1}$  has low  $E_T$  threshold for eHLT
  - For startup L use only Single e HLT which is ideal for  $\tau$  tagging efficiency measurement

Selection criteria	$e\tau+e$ HLT selections
Level-1 $\tau$ , isolated electron $E_T$ [GeV] HLT e $E_T$ [GeV]	20, 10 12
L25 regional pixel seeding region $\delta\eta, \delta\phi$	0.1, 0.1
L25 cone isolation $\Delta R_{\text{iso}}, \Delta R_{\text{sig}}, p_T^{\text{LdgTr}}$	0.45, 0.07, 6 GeV/c
L3 regional pixel seeding region $\delta\eta, \delta\phi$	0.5, 0.5
L3 cone isolation $\Delta R_{\text{iso}}, \Delta R_{\text{sig}}, p_T^{\text{LdgTr}}$	0.45, 0.07, 6 GeV/c
Level 1 single isolated electron $E_T$ [GeV] HLT single electron $E_T$ [GeV]	12 15

“CMS HLT exercise” Table

Very similar thresholds

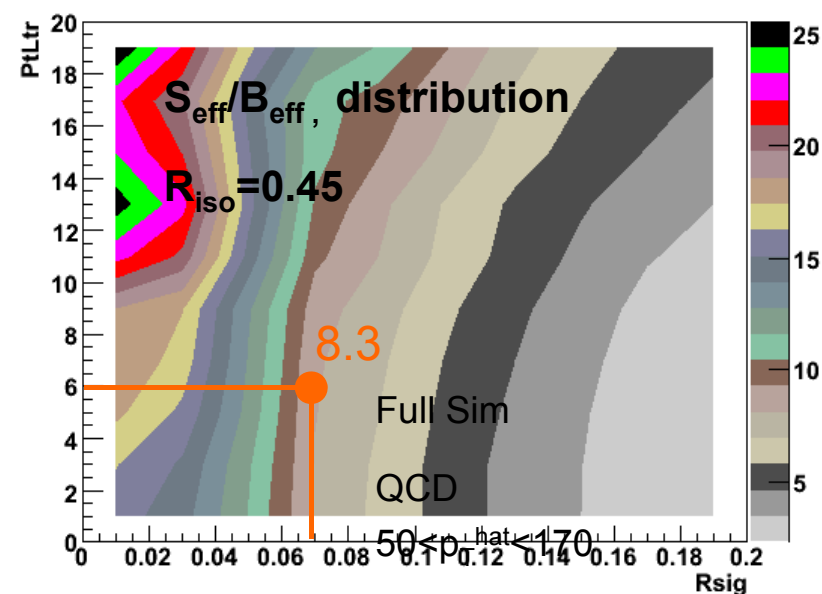
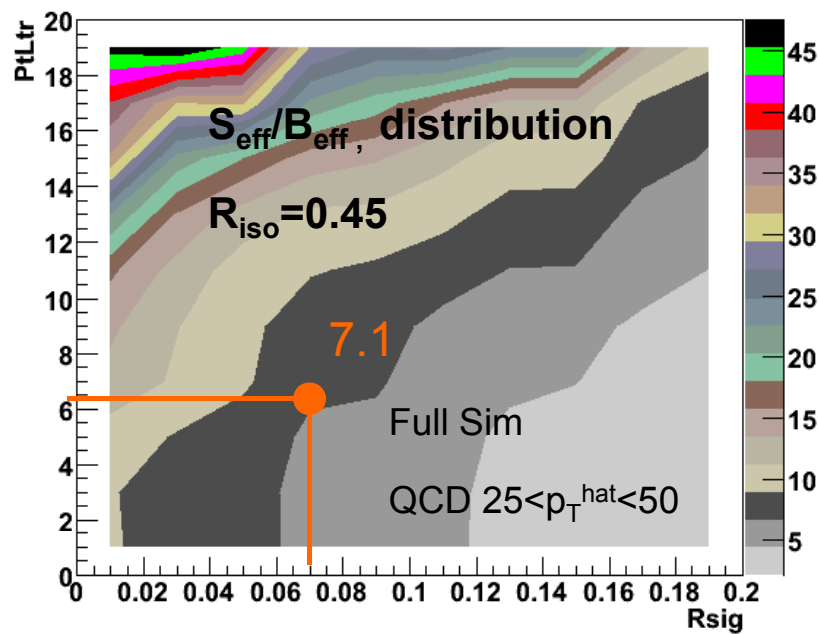
Gain of using  $e\tau$  HLT on top of e HLT is minimal both at HLT and offline

$Z \rightarrow \tau\tau \rightarrow e\tau$ -jet Selection	Efficiency
L1+HLT e	$(23.7 \pm 0.2)\%$
L1+HLT e OR $e\tau$	$(25.1 \pm 0.2)\%$
L1+HLT e + Offline	$(0.81 \pm 0.04)\%$
L1+HLT e OR $e\tau$ + Offline	$(0.83 \pm 0.04)\%$

- However as L increases, e HLT  $E_T$  threshold will need to increase accordingly
  - Gain of  $e\tau$  HLT on top of e HLT will be more evident

# $\tau$ id tightening

- Look at isolation + leading track finding efficiency in Signal QCD  $25 < p_T^{\text{hat}} < 50$  and QCD  $50 < p_T^{\text{hat}} < 170$



“Per jet” efficiency w.r.t jets that pass:

$$E_T^{\tau \text{ cand}} > 20 \text{ GeV},$$

$$E_{T3 \times 3}^{\text{HT}} / P_T^{\text{Ldg}} > 0.1,$$

$$\Delta \eta_{\text{LdgTr-HTmax}} < 0.1,$$

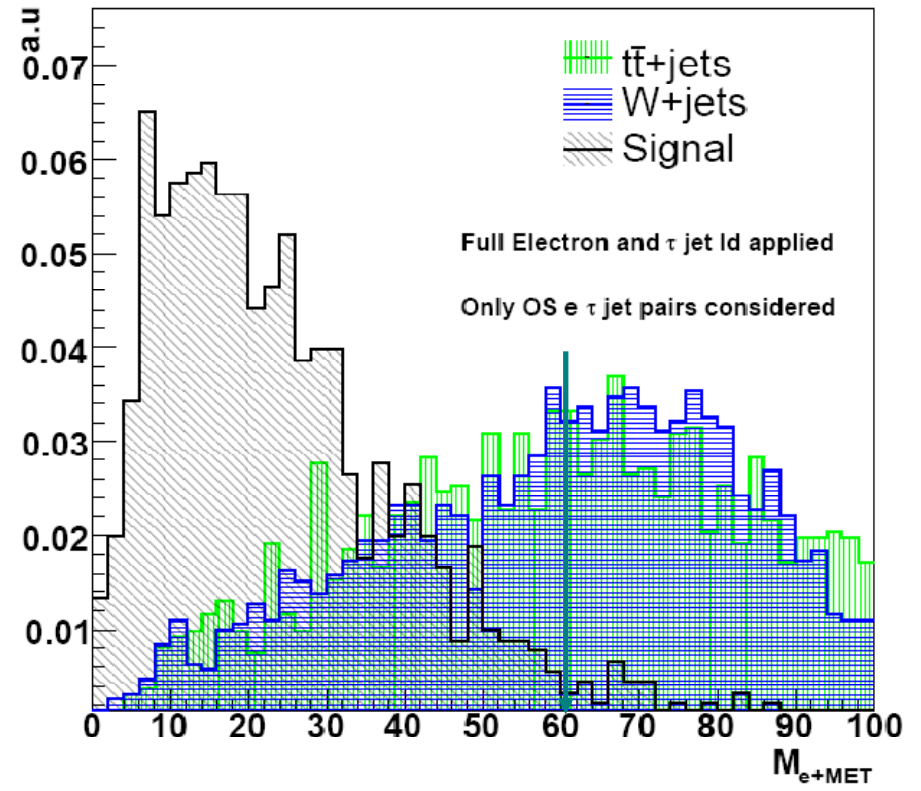
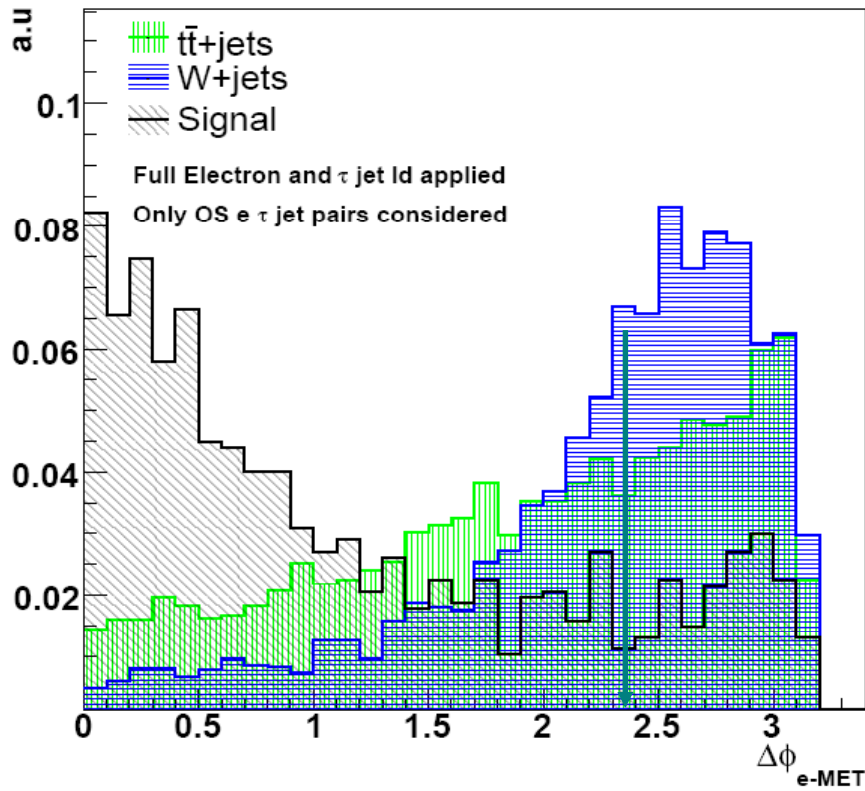
Tighten cuts:  $R_{\text{sig}} = 0.05$ ,  $P_T^{\text{LdgTr}} > 16 \text{ GeV}$

QCD\_25\_50 per jet S/B ~ 22

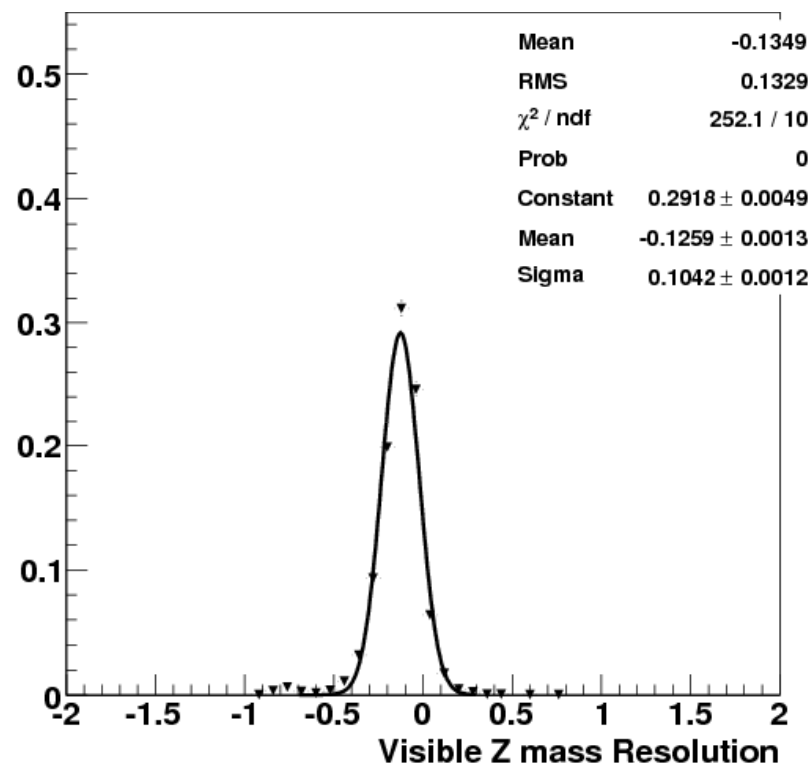
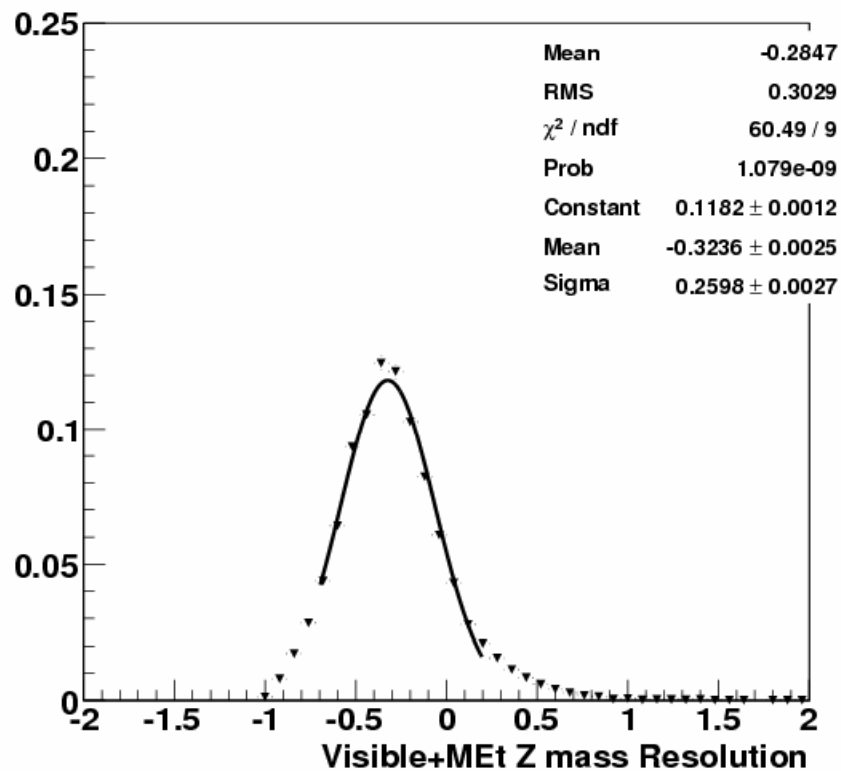
QCD\_50\_170 per jet S/B ~ 15



# Kinematic Variables



# Mass Resolutions

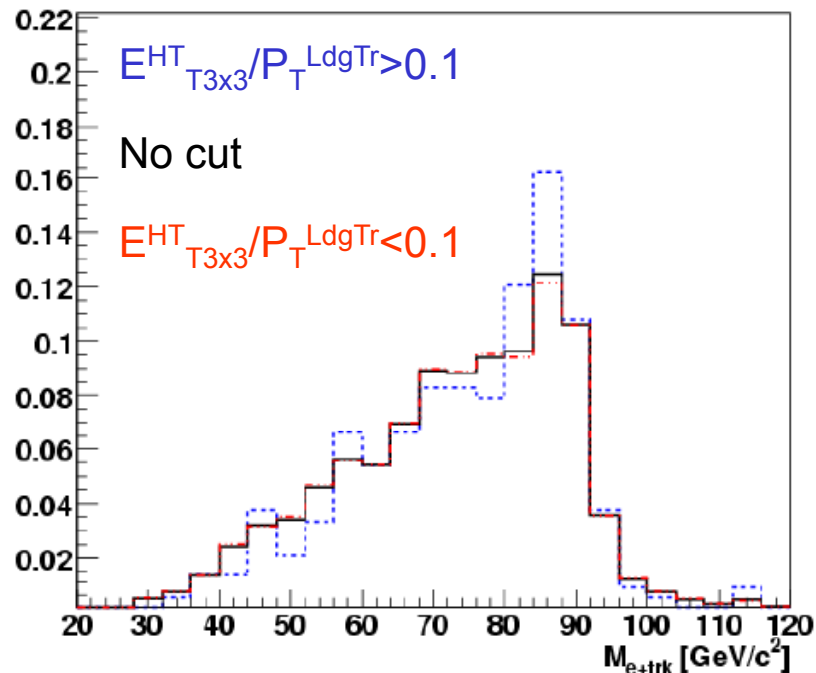


# Measuring Electron Rejection Efficiency on Electrons using $Z \rightarrow ee$

- Based on tag-probe method used by Egamma people
  - Use events triggered by Single Iso elec HLT
  - **Tag**: electron passing offline and HLT Id – Require only 1 per event
  - **Probe**:  $\tau$  candidate passing isolation but without applying e-rej criteria AND not collinear to Tag electron
  - Then plot  $M_{(\text{tag-probe})}$  for:
    - a) No e-rejection criteria applied. Events in window =  $N_{\text{tot}}$
    - b) With reversed e-rejection ( $\tau$ -veto) criteria applied. Events in window =  $N_{\tau \text{ veto}}$
  - Contrary to tag-probe method of Egamma we define  $M_{(\text{tag-probe})}$  energy and direction of  $\tau$  candidate and not track information.
  - $\epsilon_{\tau \text{ veto}} = N_{\tau \text{ veto}} / N_{\text{tot}}$  and hence can get the e-rej efficiency  $\epsilon_{e \text{ veto}} = 1 - \epsilon_{\tau \text{ veto}}$

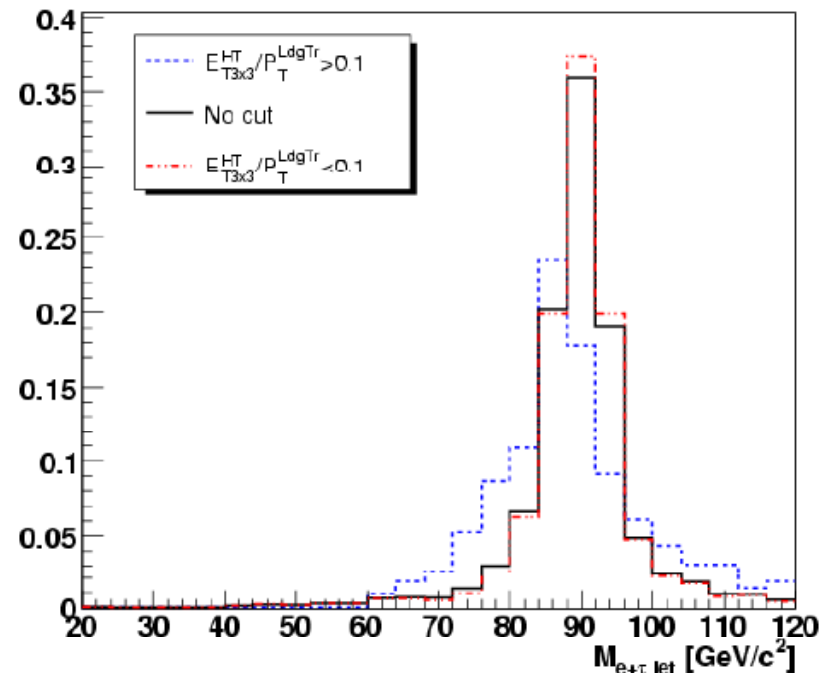
# View of $M_{(\text{tag}+\text{probe})}$

Probe = Ctf Track of 1-prong  $\tau$  candidate



Large lower tail since combining “good” electron with CTF track of calo  $\tau$  matching 2<sup>nd</sup> MCE from Z that does not appear in elec cand list (Bad elec)

Probe = Calo Jet of  $\tau$  candidate

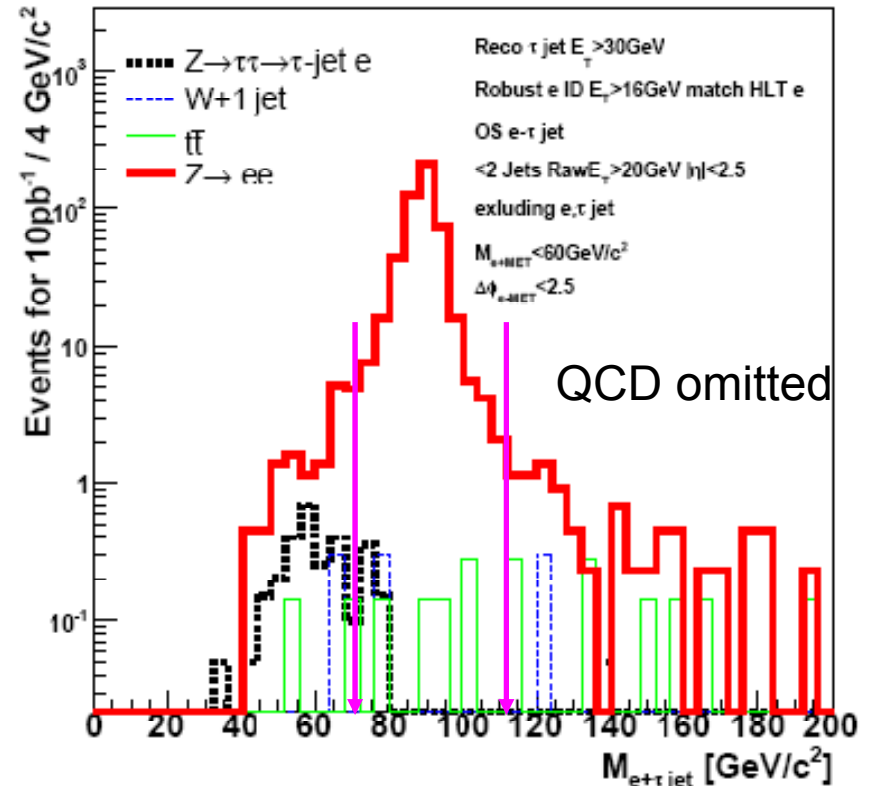
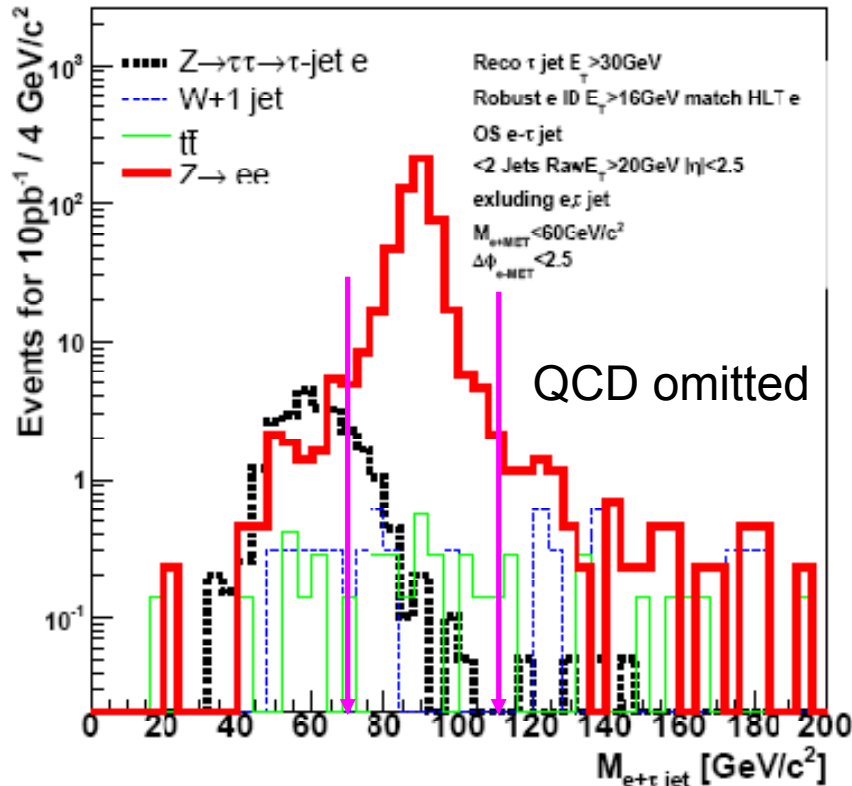


Combining good electron with calo  $\tau$  matching 2<sup>nd</sup> MCE from Z. Mass is recovered. Mass shape discrepancy due to HCAL. (extent of difference under investigation)

# Feasibility of measurement

$M_{e+\tau \text{ jet}}$  for Z->ee and backgrounds with no e-rej criteria applied

$M_{e+\tau \text{ jet}}$  for Z->ee and backgrounds with reverse e-rej ( $\tau$  veto) criteria applied



>100 times more Z->ee than backgrounds within window. Can easily extract  $N_{\text{tot}}$  and  $N_{\tau \text{ veto}}$  and hence  $\epsilon_{e \text{ veto}} = 1 - N_{\tau \text{ veto}} / N_{\text{tot}}$  and  $N_{e \text{ veto}} = N_{\tau \text{ veto}} \times (1 - \epsilon_{\tau \text{ veto}}) / \epsilon_{\tau \text{ veto}}$

Effect of QCD is under estimation

## Tau tagging efficiency measurement method (I)

- Method based on CMS Note 2006/074 (see backup)

(A. Nikitenko, A. Kalinowski ). ORCA based, 30fb<sup>-1</sup>

- Ratio of x-sections of  $Z \rightarrow ll / Z \rightarrow \tau\tau \rightarrow l + \tau\text{-jet}$  using events ( $l = e$  in this study) which fire single-lepton trigger

$$\epsilon_{\tau \text{ tag}} = \frac{N_{e\tau \text{ jet}}^{\text{meas}} - N_{e\tau \text{ jet}}^{\text{bkg}}}{N_{ee}^{\text{meas}} - N_{ee}^{\text{bkg}}} \times \frac{BR(Z \rightarrow ee)}{BR(Z \rightarrow \tau\tau \rightarrow e \tau\text{-jet})} \times \frac{\epsilon_{HLT_{1e}^{ee}}}{\epsilon_{HLT_{1e}^{e\tau \text{ jet}}}} \times \frac{\epsilon_{\text{mass reco}}^{ee}}{\epsilon_{\text{mass reco}}^{e\tau \text{ jet}}}$$

- Parameters which can be extracted from data:

- $N_{e+\tau\text{-jet}}^{\text{meas}}, N_{ee}^{\text{meas}}$ ,
- $Br(Z \rightarrow ee), Br(Z \rightarrow e + \tau)$  from e.g LEP

- Parameters known from MC or data:

- $N_{e+\tau\text{-jet}, ee}^{\text{bkg}}, \text{eff}_{HLT}, \text{eff}_{\text{mass reco}}$

# Tau tagging efficiency measurement method (II)

- Definition of efficiencies

- Want to measure  $\tau$  tagging efficiency on as a pure sample of  $\tau$  jets as possible, so apply electron rejection selections with efficiency  $\varepsilon_{\tau q}$  before  $\tau$  Id is applied

$$\varepsilon_{\text{mass reco}}^{e\tau \text{ jet}} = \varepsilon_{e E_T} \times \varepsilon_{\tau E_T} \times \varepsilon_{\tau q} \times \varepsilon_{m_T^{e-\text{MET}}} \times \varepsilon_{n\text{Jets}} \times \varepsilon_{\Delta\phi_{e\tau}} \times \varepsilon_{E_\nu} \times \varepsilon_{\text{m sel}}$$

- Definition of efficiency measured in note

- For purpose of note Ldg Track finding efficiency was factored in efficiency

$$\varepsilon_{\tau \text{ tag}} = \varepsilon_{\text{Ldg Tr}} \times \varepsilon_{\text{iso}} \times \varepsilon_{1||3}$$

- This is a global efficiency given that electron rejection criteria are satisfied
  - Efficiency as a function of t jet  $E_\tau$  is underway